## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant : Scott A. Lerner, et al. Docket No. : IL-11135

Serial No. : Art Unit :

Filed: Examiner:

For : COMPACT REFRACTIVE IMAGING SPECTROMETER

UTILIZING IMMERSED GRATINGS

## INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents Alexandria, VA 22313-1450

Dear Sir:

Forwarded herewith is an Information Disclosure Statement, Form-1449, in the above-identified application. Copies of the cited references are enclosed: 14 U.S. Patent Documents and 1 Foreign Patent Document.

The above-mentioned disclosures, which are not admitted as prior art, are identified on the enclosed Form 1449.

Respectfully submitted,

Dated: August 21, 2003

Eddie E. Scott

Attorney for Applicant Registration No. 25,220

Enclosures: As noted above

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Substitute Co. Comp. 14404 /DTO	Complete if Known			
Substitute for form 1449A/PTO	Application Number			
INFORMATION DISCLOSURE	Filing Date			
STATEMENT BY APPLICANT	First Named Inventor	Scott A. Lerner, et al.		
(use as many sheets as necessary)	Group Art Unit			
	Examiner Name			
Sheet 1 of 1	Attorney Docket Number	IL-11135		

				I.S. PATENT DOCUI	MENTO			
Examiner Initials*	Cite No.1			Name of Patentee or Applicant of Cited Document	Cited D	ublication of ocument O-YYYY	Pages, Columns, Lines, Where Relevant Passages of Relevant Figures Appear	
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Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document Office <sup>3</sup> Number <sup>4</sup> Kind Code <sup>5</sup> (if known)		Name of Patentee or Applicant of Cited Document	Cited Document F		Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
		WO 99/63311		Ansley, et al.	12-09-199	9		
Examiner Signature	- 1			Date Consider	ed			

<sup>\*</sup>Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>&</sup>lt;sup>1</sup> Unique citation designation number. <sup>2</sup> See attached Kinds of U.S. Patent Documents. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup> Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup> Applicant is to place a check mark here if English language Translation is attached. SEND TO: Commissioner for Patents, Washington, DC 20231.